

Applicant:	Kyocera
FCC ID:	V65SA001
Report #:	CT-001-Probe-0809-R0

EXHIBIT 9 APPENDIX C: SAR PROBE CALIBRATION CERTIFICATE

Total pages including cover page = 17

ES3DV3 SN:3036 September 18, 2008

Probe ES3DV3

SN:3036

Manufactured:

August 21, 2003

Last calibrated:

October 22, 2007

Recalibrated:

September 18, 2008

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

Certificate No: ES3-3036_Sep08

DASY - Parameters of Probe: ES3DV3 SN:3036

	Sensitivity in	Free Space ^A	Diode Compression ^B
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NormX	1.22 ± 10.1%	μV/(V/m) ²	DCP X	91 mV
NormY	1.40 ± 10.1%	μV/(V/m)²	DCP Y	94 mV
NormZ	1.43 ± 10.1%	$\mu V/(V/m)^2$	DCP Z	93 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL 835 MHz Typical SAR gradient: 5 % per mm

Sensor Center to	3.0 mm	4.0 mm	
SAR _{be} [%]	Without Correction Algorithm	12.1	8.1
SAR _{be} [%]	With Correction Algorithm	0.7	0.4

TSL 1900 MHz Typical SAR gradient: 10 % per mm

Sensor Center t	3.0 mm	4.0 mm	
SAR _{be} [%]	Without Correction Algorithm	11.7	7.9
SAR _{be} [%]	With Correction Algorithm	0.4	0.2

Sensor Offset

Probe Tip to Sensor Center 2.0 mm

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

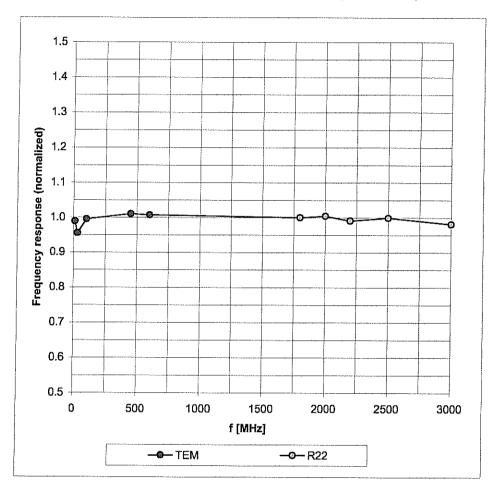
Certificate No: ES3-3036_Sep08

A The uncertainties of NormX,Y,Z do not affect the E2-field uncertainty inside TSL (see Page 8).

^B Numerical linearization parameter: uncertainty not required.

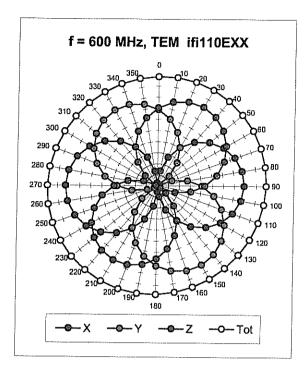
Frequency Response of E-Field

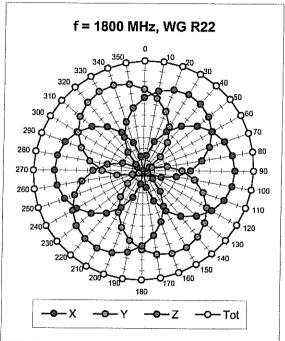
(TEM-Cell:ifi110 EXX, Waveguide: R22)

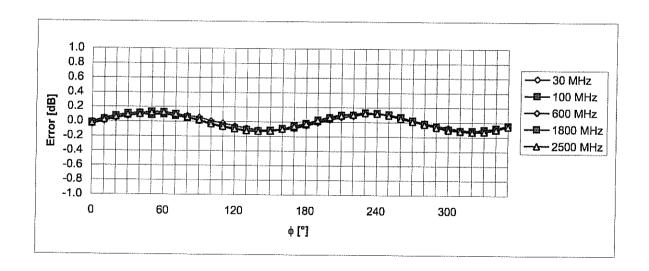


Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

Receiving Pattern (ϕ), ϑ = 0°



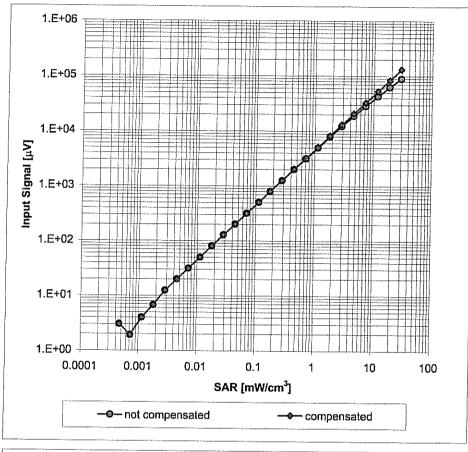


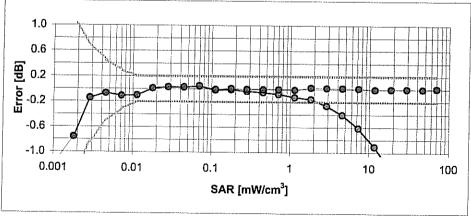


Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Dynamic Range f(SAR_{head})

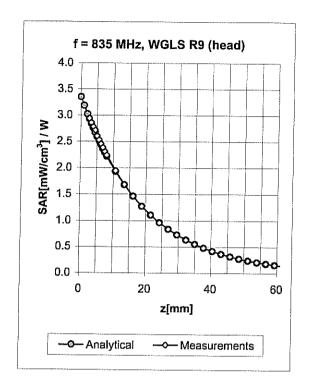
(Waveguide R22, f = 1800 MHz)

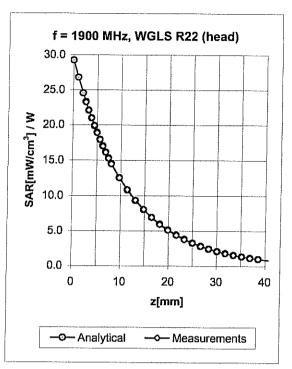




Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Conversion Factor Assessment



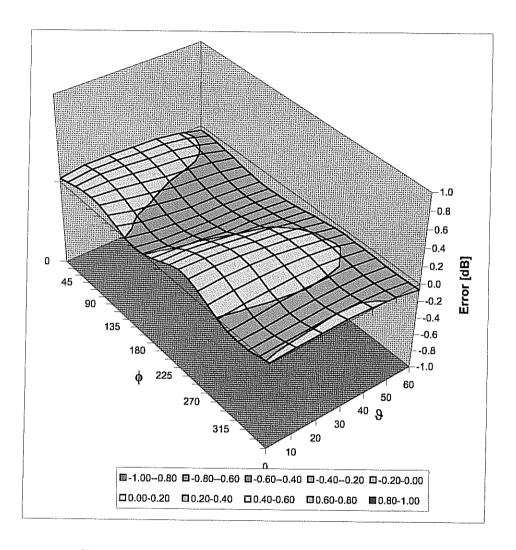


f [MHz]	Validity [MHz] ^c	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
835	± 50 / ± 100	Head	41.5 ± 5%	0.90 ± 5%	0.62	1.46	6.09 ± 11.0% (k=2)
1900	± 50 / ± 100	Head	40.0 ± 5%	1.40 ± 5%	0.40	1.98	5.02 ± 11.0% (k=2)
835	± 50 / ± 100	Body	55.2 ± 5%	0.97 ± 5%	0.99	1.09	5.97 ± 11.0% (k=2)
1900	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.40	2.02	4.56 ± 11.0% (k=2)

 $^{^{\}rm c}$ The validity of \pm 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Deviation from Isotropy in HSL

Error (ϕ , ϑ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura S **Swiss Calibration Service**

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates Accreditation No.: SCS 108

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Client

Kyocera USA

Certificate No: 🗐 3:1663 Sep08

GALBRATION GERTIFICATE ET3DV6 - SN:1663 Object OA CAL-01 v6 and OA CAL-23 v3 Calibration procedure(s) Calibration procedure for dosimetric E-field probes September 22, 2008 Calibration date: In Tolerance Condition of the calibrated item This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate, All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards Cal Date (Certificate No.) Scheduled Calibration Power meter E4419B GB41293874 1-Apr-08 (No. 217-00788) Apr-09 MY41495277 1-Apr-08 (No. 217-00788) Apr-09 Power sensor E4412A Apr-09 Power sensor E4412A MY41498087 1-Apr-08 (No. 217-00788) 1-Jul-08 (No. 217-00865) Jul-09 Reference 3 dB Attenuator SN: S5054 (3c) SN: S5086 (20b) 31-Mar-08 (No. 217-00787) Apr-09 Reference 20 dB Attenuator Jul-09 Reference 30 dB Attenuator SN: S5129 (30b) 1-Jul-08 (No. 217-00866) Jan-09 Reference Probe ES3DV2 SN: 3013 2-Jan-08 (No. ES3-3013_Jan08) 9-Sep-08 (No. DAE4-660_Sep08) Sep-09 DAE4 SN: 660 Scheduled Check Secondary Standards ID# Check Date (in house) US3642U01700 In house check: Oct-09 RF generator HP 8648C 4-Aug-99 (in house check Oct-07) US37390585 In house check: Oct-08 18-Oct-01 (in house check Oct-07) Network Analyzer HP 8753E Signature Name Function Calibrated by: Katja Pokovic Technical Manager Niels Kuster Quality Manager Approved by: Issued: September 22, 2008

Certificate No: ET3-1663 Sep08

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Calibration Laboratory of

Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurlch, Switzerland





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Service suisse d'étalonnage
Servizio svizzero di taratura
Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

TSL tissue simulating liquid NORMx,y,z sensitivity in free space

ConvF sensitivity in TSL / NORMx,y,z
DCP diode compression point
Polarization φ rotation around probe axis

Polarization 9 9 rotation around an axis that is in the plane normal to probe axis (at

measurement center), i.e., $\vartheta = 0$ is normal to probe axis

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization θ = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide). NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

Certificate No: ET3-1663_Sep08 Page 2 of 9

ET3DV6 SN:1663

Probe ET3DV6

SN:1663

Manufactured: February 8, 2002
Last calibrated: October 22, 2007
Modified: September 18, 2008
Recalibrated: September 22, 2008

Calibrated for DASY Systems

(Note: non-compatible with DASY2 system!)

DASY - Parameters of Probe: ET3DV6 SN:1663

Sensitivity in Fre	e Space ^A	Diode C	ompression	В	
NormX	2.08 ± 10.1%	μV/(V/m)²	DCP X	91 mV	
NormY	1.75 ± 10.1%	μV/(V/m) ²	DCP Y	93 mV	

NormY 1.75 ± 10.1% $\mu V/(V/m)^2$ DCP Y 93 mV NormZ 2.19 ± 10.1% $\mu V/(V/m)^2$ DCP Z 92 mV

Sensitivity in Tissue Simulating Liquid (Conversion Factors)

Please see Page 8.

Boundary Effect

TSL 835 MHz Typical SAR gradient: 5 % per mm

Sensor Center t	3.7 mm	4.7 mm	
SAR _{be} [%]	Without Correction Algorithm	10.5	6.1
SAR _{be} [%]	With Correction Algorithm	8.0	0.5

TSL 1900 MHz Typical SAR gradient: 10 % per mm

Sensor Center t	3.7 mm	4.7 mm	
SAR _{be} [%]	Without Correction Algorithm	12.3	7.5
SAR _{be} [%]	With Correction Algorithm	0.9	0.2

Sensor Offset

Probe Tip to Sensor Center 2.7 mm

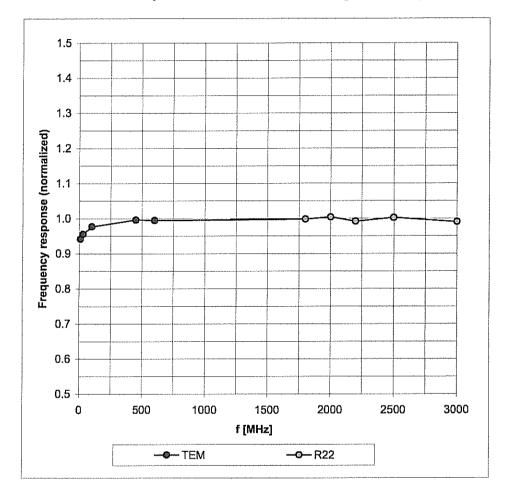
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^B Numerical linearization parameter: uncertainty not required.

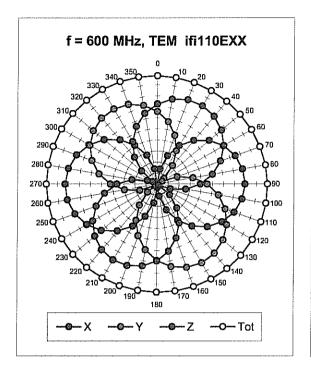
Frequency Response of E-Field

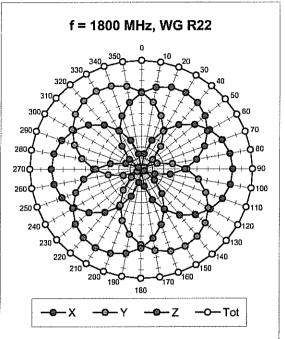
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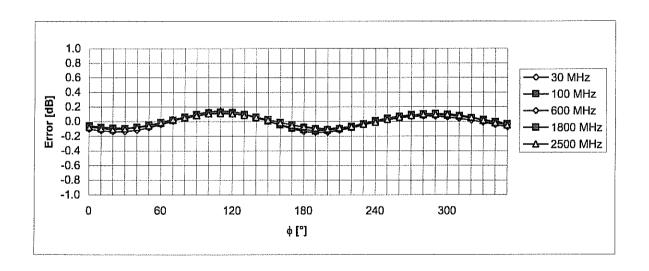


Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



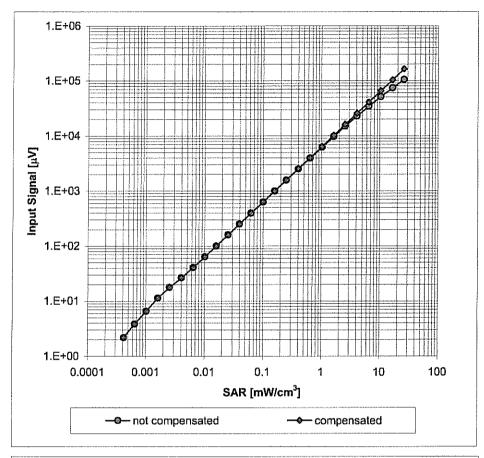


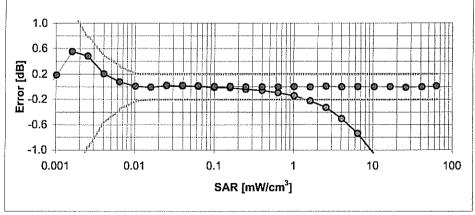


Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Dynamic Range f(SAR_{head})

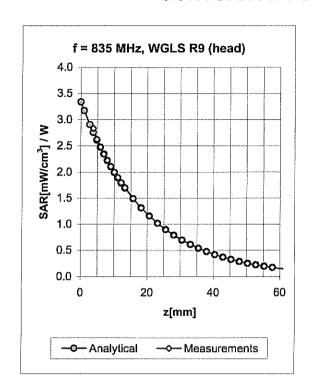
(Waveguide R22, f = 1800 MHz)

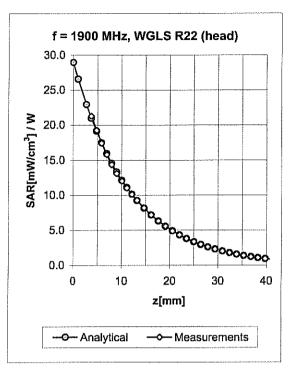




Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Conversion Factor Assessment



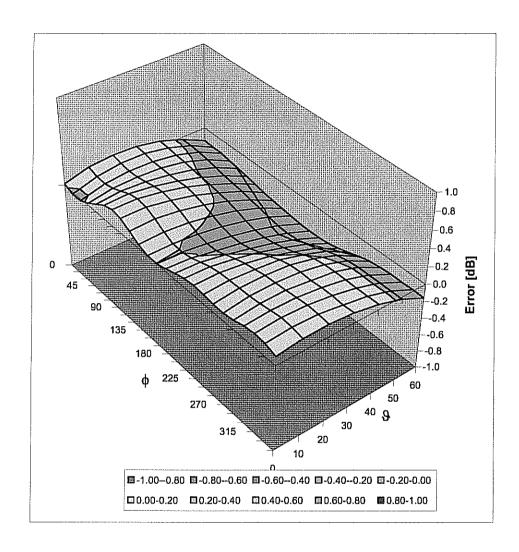


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835	± 50 / ± 100	Body	55.2 ± 5%	0.97 ± 5%	0.23	3.46	6.25	± 11.0% (k=2)
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^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Deviation from Isotropy in HSL

Error (ϕ , ϑ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)